

Features

- 3 kA, 8/20 µs surge capability
- Low clamping voltage under surge
- Bidirectional TVS
- Excellent performance over temperature
- **S** UL Recognized (pending)

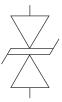
PTVS3-xxxC-TH Series High Current TVS Diodes

Applications

■ High power DC bus protection

General Information

The Model PTVS3-xxxC-TH Series high current bidirectional TVS diodes are designed for use in high power DC bus clamping applications. These devices offer bidirectional port protection and are available with standoff voltage ratings of 58 V and 76 V.



The devices are RoHS* compliant and UL Recognized (pending). They also meet IEC 61000-4-5 8/20 μs current surge requirements.

Absolute Maximum Ratings (@ T_A = 25 °C Unless Otherwise Noted)

Rating	Symbol	Value	Unit	
Repetitive Standoff Voltage PTVS3-058C-TH PTVS3-076C-TH		V _{WM}	58 76	V
Peak Current Rating per 8/20 µs IEC 61000-4-5		I _{PPM}	3	kA
Operating Junction Temperature Range		ТJ	-40 to +125	°C
Storage Temperature Range		т _s	-55 to +150	°C
Lead Temperature, Soldering (10 s)		260	°C	

Electrical Characteristics (@ T_A = 25 °C Unless Otherwise Noted)

Parameter		Test Conditions		Min.	Тур.	Max.	Unit
ID	Standby Current	$V_{D} = V_{WM}$				10	μA
V _(BR)	Breakdown Voltage	I _{BR} = 10 mA	PTVS3-058C-TH PTVS3-076C-TH	64 85	67 90	70 95	v
V _C	Clamping Voltage $^{(1)}$ per IEC61000-4-5 (8/20 μ s current waveform)	I _{PP} = 3 kA	PTVS3-058C-TH PTVS3-076C-TH			110 140	v
V _(BR)) Temperature Coefficient				0.1		%/°C
С	Capacitance	F = 10 kHz, V _d = 1 Vrms	PTVS3-058C-TH PTVS3-076C-TH		2.3 1.7		nF

 $^{(1)}$ V_C measured at the time which is coincident with the peak surge current.



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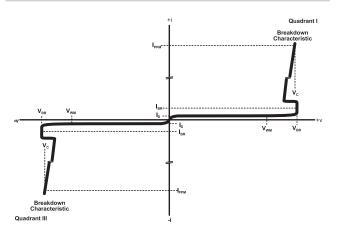
*RoHS Directive 2002/95/EC Jan. 27, 2003 including annex and RoHS Recast 2011/65/EU June 8, 2011. Specifications are subject to change without notice. The device characteristics and parameters in this data sheet can and do vary in different applications and actual device performance may vary over time. Users should verify actual device performance in their specific applications.

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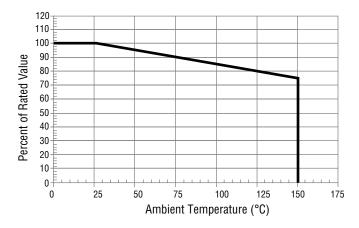
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Performance Graphs

V-I Characteristic

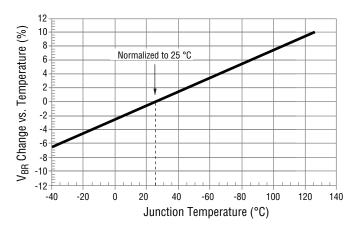


Typical Surge Current Derating



This graph shows the typical device surge current derating versus ambient temperature when subjected to the $8/20 \,\mu s$ current waveform per the IEC 61000-4-5 specification. This device is not intended for continuous operation at temperatures above 125 °C.

Percentage V_{BR} Change vs. Junction Temperature



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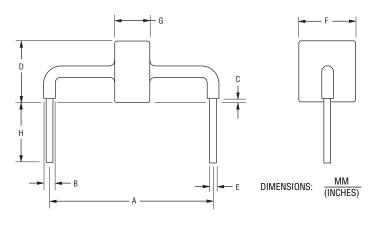
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Product Dimensions

Typical Part Marking

Epoxy encapsulation materials conform to UL 94V-0. Silver plated lead finish conforms to the solderability requirements of JESD22-B102, Pb free solder. Package dimensions are shown below:



Dim.	PTVS3-058C-TH	PTVS3-076C-TH		
Α	24.15 ± 0.72			
~	(0.951 ± 0.028)			
в		2.40 ± 0.50		
В	(0.094 ±	$\overline{(0.094 \pm 0.020)}$		
с	1.75 ± 1.25			
	$\overline{(0.069 \pm 0.049)}$			
р	10.80 Mox			
	$\frac{10.00}{(0.425)}$ Max.			
E	1.25 ± 0.05			
	(0.049 ± 0.002)			
F	<u>9.30</u> Max.			
I	(0.366) Wax.			
G	<u>5.00</u> (0.197) Max.	<u>6.00</u> (0.236) Max.		
н	6.00 ± 1.00			
(0.236 ± 0.039)		: 0.039)		

How to Order	
Series	PTVS 3 - 076 C - T H
Peak Current Rating 3 = 3 kA	
Repetitive Standoff Voltage	
SuffixC = Bidirectional Device	
Package T = Through-Hole	
Temperature	

H = High Temperature Series

03/14

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